



# APPROVAL SHEET

Approval Specification	Customer's Approval Certificate
<b>TO:</b>  <b>Part No.:</b>  <b>Customer's Part No.:</b>	Please return this copy as a certification of your approval  <b>Checked &amp; Approved by:</b>  <b>Date:</b>

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**Application**

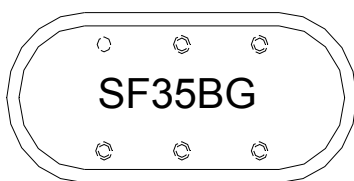
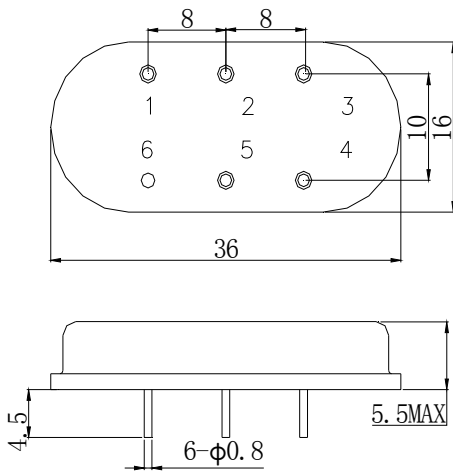
- Low-loss SAW component
- Low amplitude ripple
- Sharp rejections at both out-bands
- Usable passband 4.5 MHz

**Features**

- RoHS compatible
- Package size 39.1x26.1x7.50mm<sup>3</sup>
- Package Code SB01-02
- Electrostatic Sensitive Device(ESD)



**Package Dimensions (Unit: mm)**



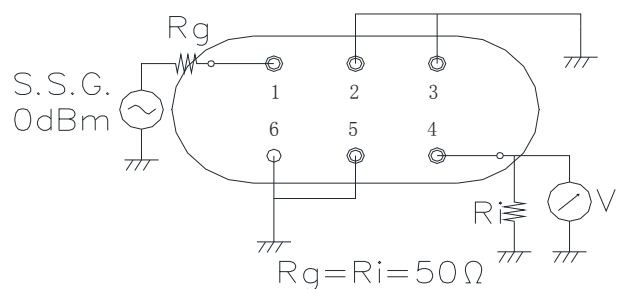
**Pin Configuration**

Pin No.	Description
1	Input
4	Output
1,2,3,5	Ground

**Marking Description**

<b>S</b>	Trademark
<b>F</b>	SAW Filter
<b>35BG</b>	Part Number

**Test Circuit**



**Performance****Maximum Rating**

Item		Value	Unit
DC Voltage	V <sub>DC</sub>	3	V
Operation Temperature	T	-40 ~ +85	°C
Storage Temperature	T <sub>stg</sub>	-55 ~ +125	°C
RF Power Dissipation	P	10	dBm

**Electronic Characteristics**

Test Temperature: 25°C ± 2°C

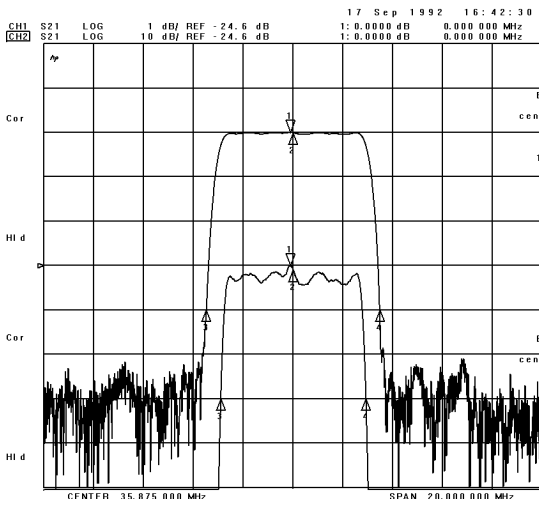
Terminating source impedance: 50Ω

Terminating load impedance: 50Ω

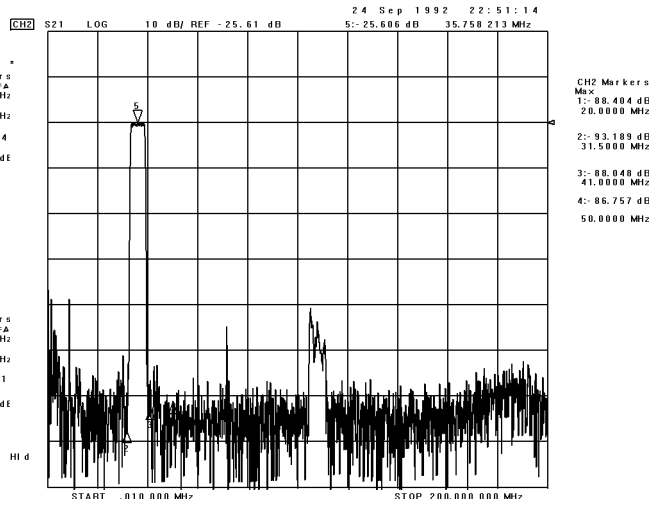
Item		Minimum	Typical	Maximum	Unit
Center Frequency	f <sub>c</sub>		35.875		MHz
Insertion Loss(min)	IL		25.0	30.0	dB
Amplitude Ripple (p-p) 34.00-38.50MHz	Δα		0.4	0.6	dB
Amplitude Ripple (p-p) 33.00-38.75 MHz	Δα		2.3	2.5	dB
Group Delay Ripple(relative to 38.00 MHz) 34.00-38.50MHz	GDR		120.0	150.0	ns
Absolute Attenuation	α				
20.00-31.50 MHz		40.0	53.0		dB
32.50 MHz		26.0	28.0		dB
39.25 MHz		26.0	28.0		dB
41.00-60.00 MHz		40.0	53.0		dB
60.00-200.00 MHz		35.0	40.0		dB

Frequency Characteristics

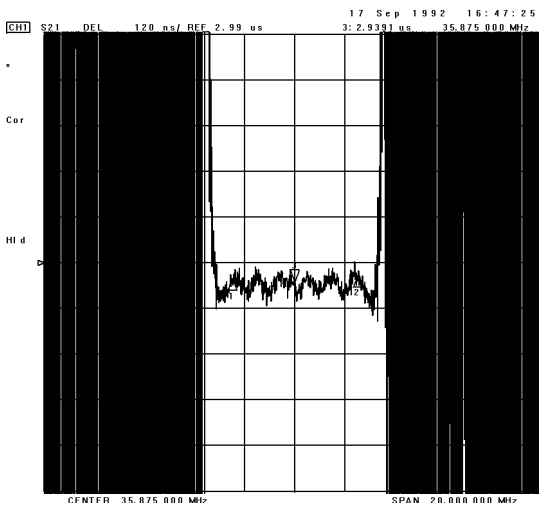
Frequency Response



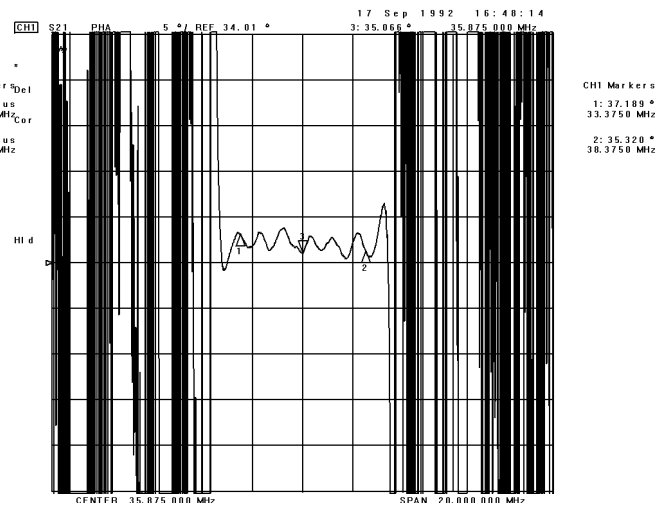
Frequency Response (wideband)



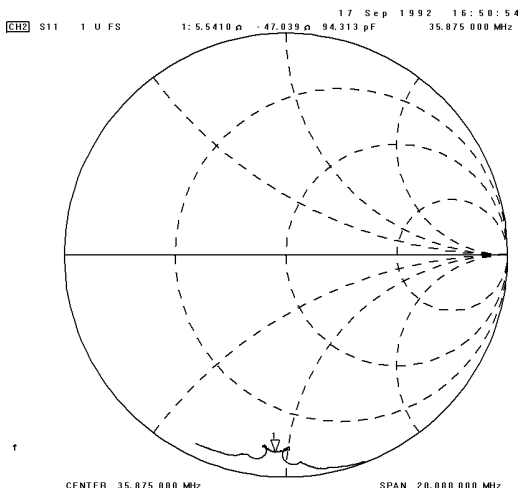
Delay Ripple



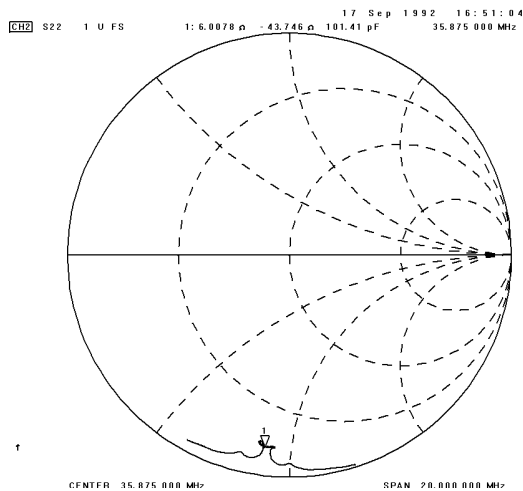
Phase Linearity



S11 Smith Chart

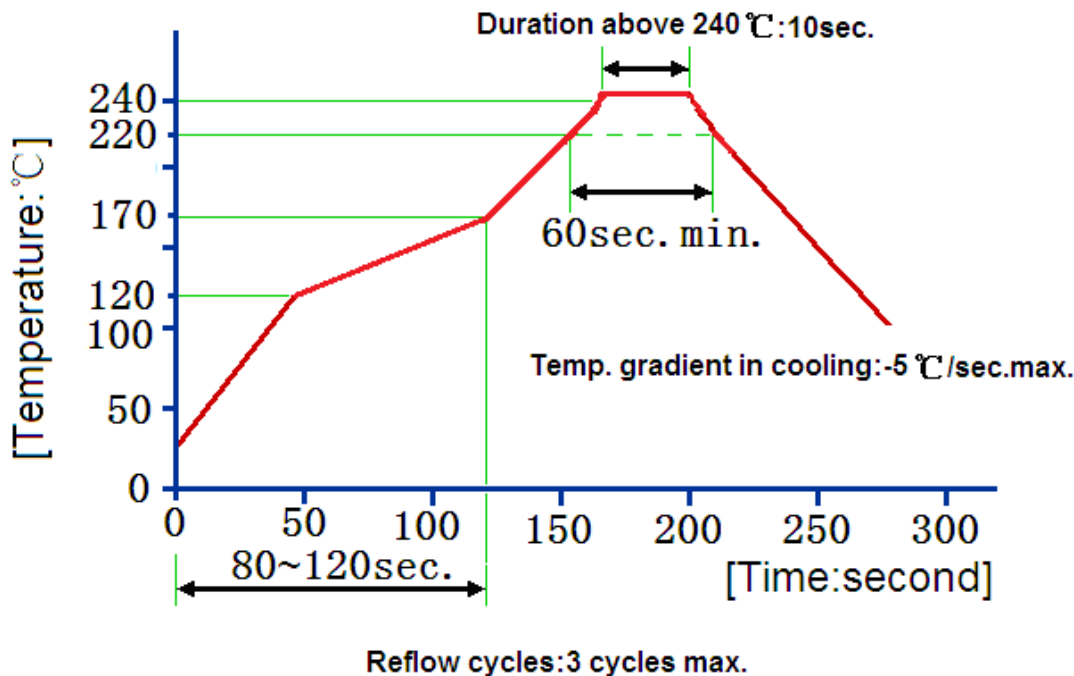


S22 Smith Chart



**Reliability (The SAW components shall remain electrical performance after tests)**

No.	Test item	Test condition
1	Temperature Storage	(1) Temperature: $85^{\circ}\text{C}\pm 2^{\circ}\text{C}$ , Duration: 250h , Recovery time: $2\text{h}\pm 0.5\text{h}$ (2) Temperature: $-55^{\circ}\text{C}\pm 3^{\circ}\text{C}$ , Duration: 250h , Recovery time: $2\text{h}\pm 0.5\text{h}$
2	Humidity Test	Conditions: $60^{\circ}\text{C}\pm 2^{\circ}\text{C}$ , 90~95% RH                      Duration: 250h
3	Thermal Shock	Heat cycle conditions: $\text{TA}=-55^{\circ}\text{C}\pm 3^{\circ}\text{C}$ , $\text{TB}=85^{\circ}\text{C}\pm 2^{\circ}\text{C}$ , $t_1=t_2=30\text{min}$ , Switch time: $\leq 3\text{min}$ , Cycle time: 100 times, Recovery time: $2\text{h}\pm 0.5\text{h}$ .
4	Vibration Fatigue	Frequency of vibration: 10~55Hz                      Amplitude: 1.5mm Directions: X,Y and Z                      Duration: 2h
5	Drop Test	Cycle time: 10 times                      Height: 1.0m
6	Solder Ability Test	Temperature: $245^{\circ}\text{C}\pm 5^{\circ}\text{C}$ Duration: 3.0s--5.0s Depth: DIP--2/3 , SMD--1/5
7	Resistance to Soldering Heat	(1) Thickness of PCB: 1mm , Solder condition: $260^{\circ}\text{C}\pm 5^{\circ}\text{C}$ , Duration: $10\pm 1\text{s}$ (2) Temperature of Soldering Iron: $350^{\circ}\text{C}\pm 10^{\circ}\text{C}$ , Duration: 3~4s , Recovery time : $2 \pm 0.5\text{h}$

**Recommended Reflow Soldering Diagram**

**Notes**

1. As a result of the particularity of inner structure of SAW products, it easy to be breakdown by electrostatic, so we should pay attention to **ESD protect** in the test.
2. **Static voltage** between signal load and ground may cause deterioration and destruction of the component. Please avoid static voltage.
3. **Ultrasonic cleaning** may cause deterioration and destruction of the component. Please avoid ultrasonic cleaning.
4. Only leads of component may **be soldered**. Please avoid soldering another part of component.
5. There is a close relationship between the device's performance and **matching network**. The specifications of this device are based on the test circuit shown above. L and C values may change depending on board layout. Values shown are intended as a guide only.